

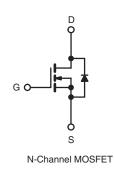
N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	60					
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	0.027				
Q _g (Max.) (nC)	95					
Q _{gs} (nC)	27					
Q _{gd} (nC)	46					
Configuration	Single					

FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available





ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, ui	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	60	- V		
Gate-Source Voltage			V _{GS}	± 20	v	
Continuous Drain Current	V _{GS} at 10 V	$T_C = 25 \degree C$ $T_C = 100 \degree C$	la la	45		
	VGS at 10 V	$T_C = 100 \degree C$	I _D	30	А	
Pulsed Drain Current ^a			I _{DM}	220	<u> </u>	
Linear Derating Factor				0.32	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	100	mJ	
Maximum Power Dissipation	T _C = 25 °C		P _D 52		W	
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	- °C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, $L = 129 \text{ }\mu\text{H}$, $R_G = 25 \Omega$, $I_{AS} = 30 \text{ A}$ (see fig. 12). c. $I_{SD} \leq 52 \text{ A}$, dI/dt $\leq 250 \text{ A}/\mu\text{s}$, $V_{DD} \leq V_{DS}$, $T_J \leq 175 \text{ °C}$.

d. 1.6 mm from case.

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THERMAL RESISTANCE RAT	TINGS								
PARAMETER	SYMBOL	ТҮР	•	MAX.			UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-		65		°044			
Maximum Junction-to-Case (Drain)	R _{thJC}	- 3.1				°C/W			
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,	unless otherv	vise noted							
PARAMETER	SYMBOL	TES		ONS	MIN.	TYP.	MAX.	UNIT	
Static									
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 2	50 μΑ	60	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	$I_D = 1 \text{ mA}$	-	0.060	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 2	250 μΑ	1.0	-	3.0	V	
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V			-	-	± 100	nA	
Zero Gate Voltage Drain Current		V _{DS} =	$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-	25	μA	
	I _{DSS}	$V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 150 ^{\circ}\text{C}$			-	-	250		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D	= 18 A ^b	-	0.027	-	Ω	
Forward Transconductance	9 _{fs}	V _{DS} =	= 25 V, I _D =	18 A ^b	15	-	-	S	
Dynamic								•	
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5 f = 1.0 MHz			-	1500	-		
Output Capacitance	C _{oss}			-	720	-	pF		
Reverse Transfer Capacitance	C _{rss}			-	100	-			
Drain to Sink Capacitance	С			-	12	-			
Total Gate Charge	Qg				-	-	95		
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		52 A, V _{DS} = 48 V, e fig. 6 and 13 ^b	-	-	27	nC	
Gate-Drain Charge	Q _{gd}	see tig		g. o and 15*	-	-	46		
Turn-On Delay Time	t _{d(on)}		1		-	19	-		
Rise Time	t _r	$\label{eq:V_DD} \begin{array}{l} {\sf V}_{\rm DD} = 30 \; {\sf V}, \; {\sf I}_{\rm D} = 52 \; {\sf A}, \\ {\sf R}_{\rm G} = 9.1 \; \Omega, \; {\sf R}_{\rm D} = 0.54 \; \Omega, \\ {\sf see \; fig. \; 10^{\rm b}} \end{array}$		-	120	-	ns		
Turn-Off Delay Time	t _{d(off)}			-	55	-			
Fall Time	t _f			-	86	-			
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from		-	4.5	-	nH		
Internal Source Inductance	L _S	package and center of			-	7.5		-	
Drain-Source Body Diode Characteristic	s							•	
Continuous Source-Drain Diode Current	١ _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	45	A		
Pulsed Diode Forward Current ^a	I _{SM}			-	-	120			
Body Diode Voltage	V _{SD}	$T_J = 25 \ ^{\circ}C, \ I_S = 30 \ A, \ V_{GS} = 0 \ V^b$		-	-	2.5	V		
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \ ^{\circ}C, \ I_F = 52 \ A, \ dI/dt = 100 \ A/\mu s^b$		-	140	300	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.2	2.8	μC		
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time i	is negligible (turn	-on is dor	ninated b	y L _S and I	_D)	

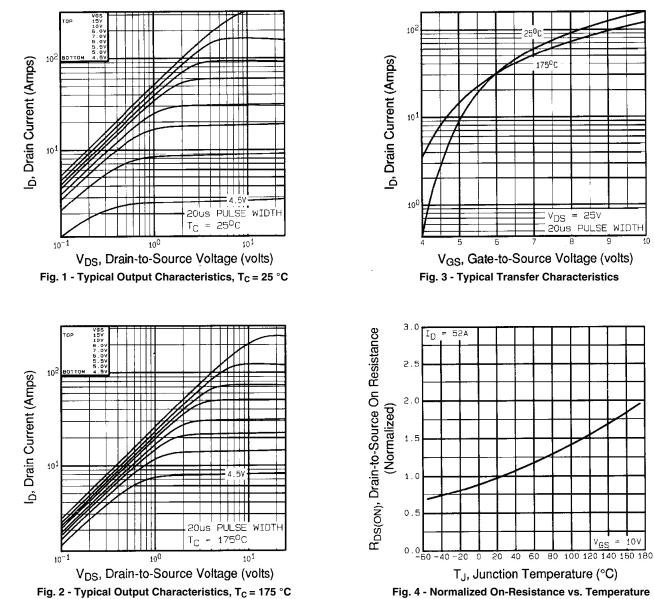
Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



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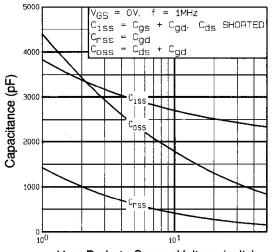
10V



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

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V_{DS}, Drain-to-Source Voltage (volts) Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

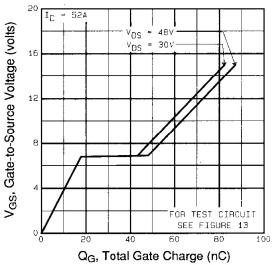


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

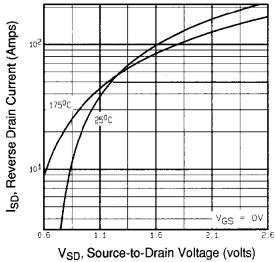
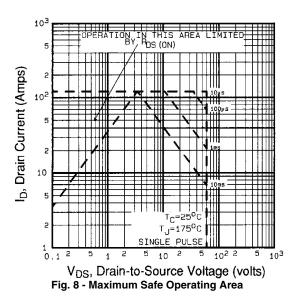


Fig. 7 - Typical Source-Drain Diode Forward Voltage



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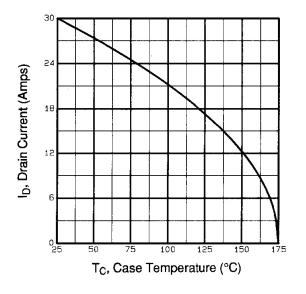


Fig. 9 - Maximum Drain Current vs. Case Temperature

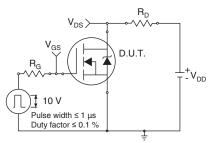


Fig. 10a - Switching Time Test Circuit

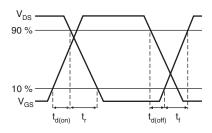


Fig. 10b - Switching Time Waveforms

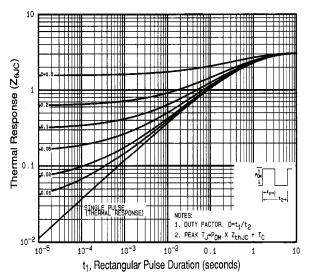


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

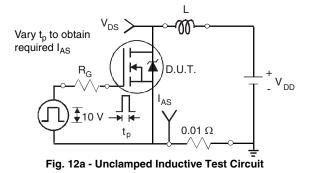
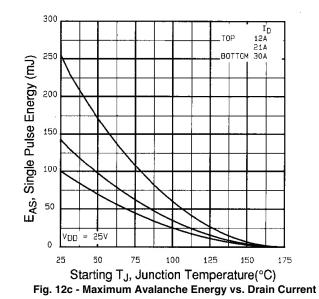


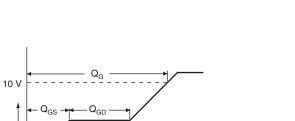
Fig. 12b - Unclamped Inductive Waveforms

DS

 $\mathsf{V}_{\mathsf{D}\mathsf{D}}$







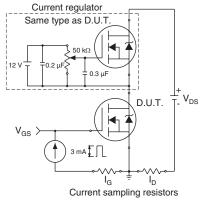


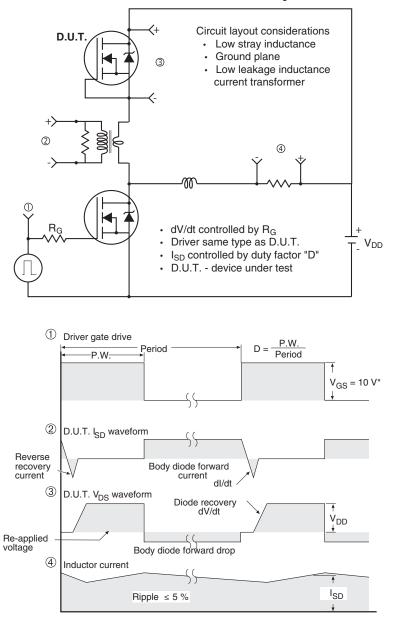
Fig. 13a - Basic Gate Charge Waveform

Charge

 V_{G}

Fig. 13b - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel



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